Applicant(s)/Patent Under Reexamination Application/Control No. 09/912,072 MOYER ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1634 Sarae Bausch **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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